

# APPLICATION DATA SHEET

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Attorney Docket Number: 102847-36

Publication Filing Type: new-utility

Application Type: utility

Title of Invention: METHOD FOR EXAMINING STRUCTURES ON A SEMICONDUCTOR  
SUBSTRATE

Attorney Docket Number: 102847-36

Customer Number Attorney: 21125



Customer Number Correspondence Address: 21125



## Continuity Data:

This application is a non-provisional of provisional 60/182,375 2000-02-14 incorporated herein by reference

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